## MOSFET – Power, Single N-Channel 90 V, 20 mΩ, 41 A

#### Features

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- High Current Capability
- Avalanche Energy Specified
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (	I <sub>J</sub> = 25°C	unless otherw	lise noted)		
Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	90	V
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain Cur-	Steady State	$T_{C} = 25^{\circ}C$	I <sub>D</sub>	41	А
rent $R_{\theta JC}$ (Notes 1 & 3)		$T_{C} = 100^{\circ}C$		29	
Power Dissipation $R_{\theta JC}$		$T_{C} = 25^{\circ}C$	PD	83	W
(Note 1)		$T_{C} = 100^{\circ}C$		42	1
Continuous Drain Current R <sub>θJA</sub> (Notes 1, 2 & 3)	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	8.7	А
		T <sub>A</sub> = 100°C		6.1	1
Power Dissipation $R_{\theta JA}$		T <sub>A</sub> = 25°C	PD	3.8	W
(Notes 1 & 2)		T <sub>A</sub> = 100°C		1.9	1
Pulsed Drain Current	T <sub>A</sub> = 25°	C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	206	А
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	–55 to 175	°C
Source Current (Body Diode)			۱ <sub>S</sub>	40	А
Single Pulse Drain-to-Source Avalanche Energy (T <sub>J</sub> = 25°C, V <sub>GS</sub> = 10 V, I <sub>L(pk)</sub> = 24.5 A, L = 0.3 mH, R <sub>G</sub> = 25 $\Omega$ )			E <sub>AS</sub>	90	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Drain)	$R_{\theta JC}$	1.8	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	40	

 The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.

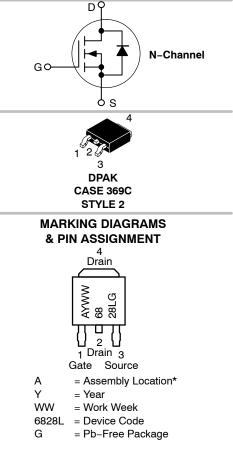
 Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



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V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>
90 V	20 mΩ @ 10 V	41 A
	25 mΩ @ 4.5 V	417



\* The Assembly Location Code (A) is front side optional. In cases where the Assembly Location is stamped in the package bottom (molding ejecter pin), the front side assembly code may be blank.

ORDERING INFORMATION				
Device	Package	Shipping <sup>†</sup>		
NVD6828NLT4G	DPAK (Pb–Free)	2500/Tape & Reel		
NVD6828NLT4G- VF01	DPAK (Pb–Free)	2500/Tape & Reel		

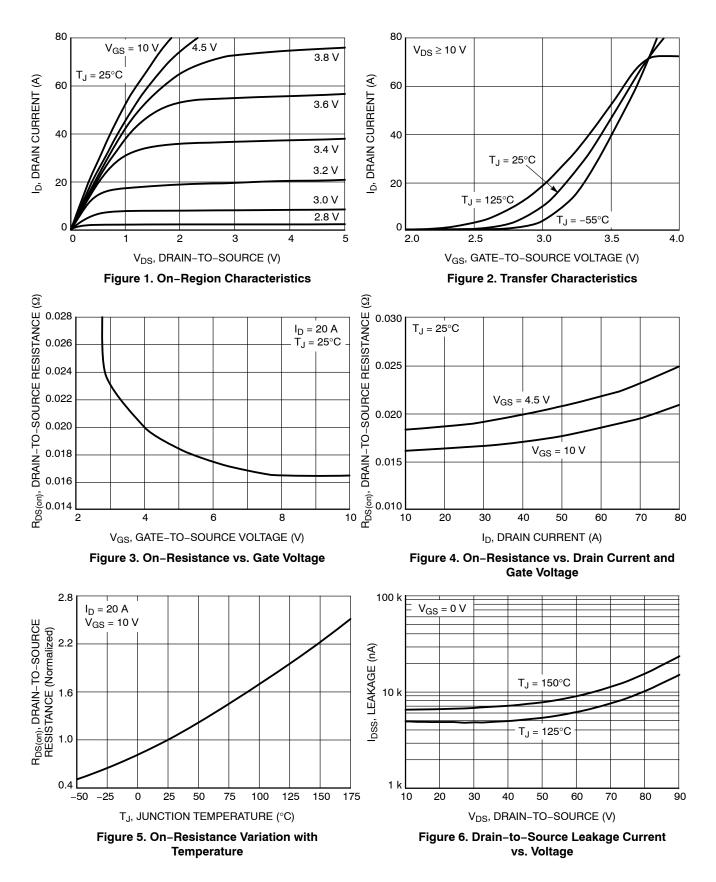
+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}C$ unless otherwise noted)

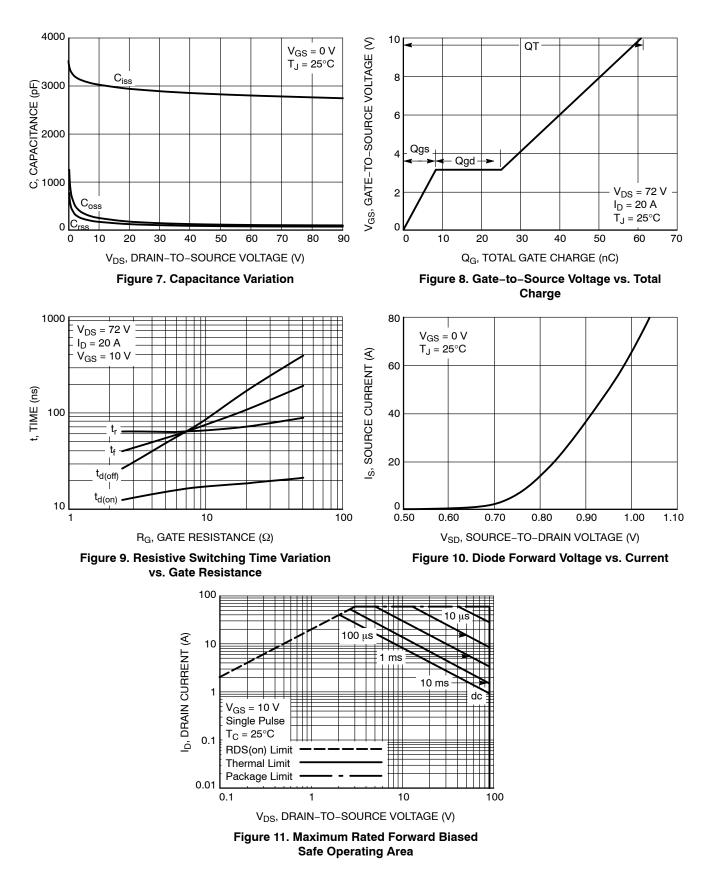
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	1 1						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> = 250 $\mu$ A		90			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				87		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 90 V	T <sub>J</sub> = 25°C T <sub>J</sub> = 125°C			1.0 100	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	•			±100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> :	= 250 μA	1.5		2.5	V
Negative Threshold Temperature Co- efficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	· · · · · · · · · · · · · · · · · · ·			-6.5		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS}$ = 10 V, I <sub>C</sub>	) = 20 A		16.5	20	mΩ
		V <sub>GS</sub> = 4.5 V, I <sub>[</sub>	<sub>0</sub> = 20 A		19.1	25	-
CHARGES, CAPACITANCES AND GA	TE RESISTANCE	S					
Input Capacitance	C <sub>iss</sub>				2900		pF
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, f = <sup>-</sup> V <sub>DS</sub> = 25	I.0 MHz, V		175		1
Reverse Transfer Capacitance	C <sub>rss</sub>	•DS = 23 •			126		1
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 72 \text{ V},$ $I_D = 20 \text{ A}$ $V_{GS} = 10 \text{ V}, V_{DS} = 72 \text{ V},$ $I_D = 20 \text{ A}$			32		nC
					61		
Threshold Gate Charge	Q <sub>G(TH)</sub>				3.3		
Gate-to-Source Charge	Q <sub>GS</sub>	$\label{eq:VGS} \begin{array}{l} V_{GS} = 10 \text{ V}, V_{DS} = 72 \text{ V}, \\ I_D = 20 \text{ A} \end{array}$			9.0		
Gate-to-Drain Charge	Q <sub>GD</sub>				16		
SWITCHING CHARACTERISTICS (Not	e 5)						
Turn-On Delay Time	t <sub>d(on)</sub>				14		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>D</sub>	<sub>D</sub> = 72 V,		64		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = 20 \text{ A}, \text{ R}_G$	= 2.5 Ω		28		
Fall Time	t <sub>f</sub>				43		
DRAIN-SOURCE DIODE CHARACTER	RISTICS						
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V,$	T <sub>J</sub> = 25°C		0.84	1.2	V
		I <sub>S</sub> = 20 A	T <sub>J</sub> = 125°C		0.72		
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dls/dt = 100 A/μs, I <sub>S</sub> = 20 A			35		ns
Charge Time	ta				25		7
Discharge Time	tb				10		
Reverse Recovery Charge	Q <sub>RR</sub>				49		nC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**



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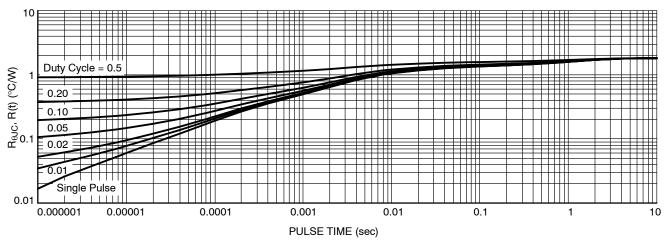
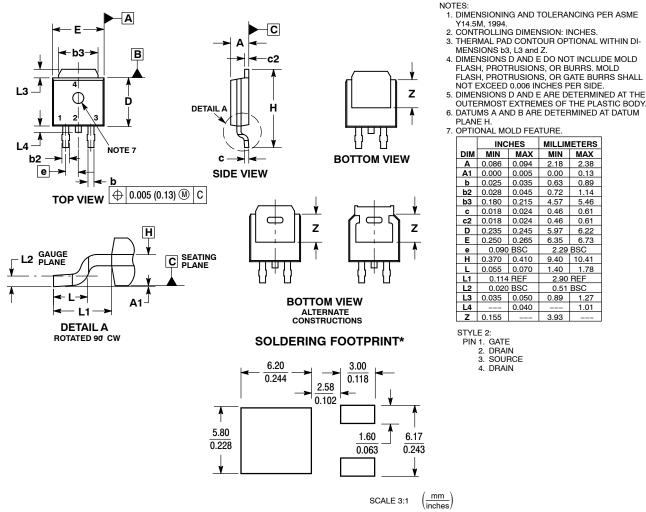


Figure 12. Thermal Response

#### PACKAGE DIMENSIONS

#### **DPAK (SINGLE GAUGE)** CASE 369C

**ISSUE F** 



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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A1 0.000 0.005

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0.018 0.024

0.250 0.265

0.090 BSC

0.370 0.410

0.055 0.070

0.114 REF

0.020 BSC

DRAIN

DRAIN

0.040

L3 0.035 0.050

**Z** 0.155

PIN 1. GATE 2. DRAIN 3. SOUR

**D** 0.235 0.245

**b3** 0.180

DIM

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L1 L2

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MIN MAX MIN MAX

2.18

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1.40 1.78 2.90 REF

0.89

3.93

2.29 BSC

9.40 10.41

0.51 BSC

MILLIMETERS

2.38

0.13

0.89

1.14

5.46

0.61

0.61

6.22

6.73

1.27

1.01

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